



MACMIC

## MM109N06K Datasheet

## N-Channel MOSFET

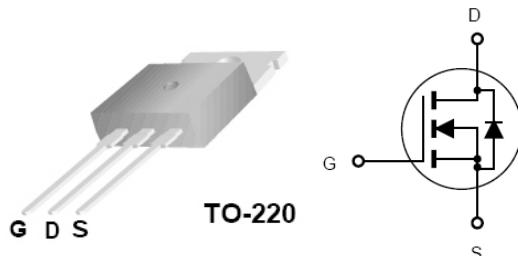
## Applications:

- Power Supply
- DC-DC Converters

V <sub>DSS</sub>	R <sub>DSON</sub> (MAX)	I <sub>D</sub> <sup>a</sup>
60V	8mΩ	109A

## Features:

- Lead Free
- Low R<sub>DSON</sub> to Minimize Conductive Loss
- Low Gate Charge for Fast Switching Application
- Optimized B<sub>VDSS</sub> Capability



## Ordering Information

Park Number	Package	Brand
MM109N06K	TO-220	MacMic

## Absolute Maximum Ratings

T<sub>C</sub>=25°C unless otherwise specified

Symbol	Parameter	Value	Unit
V <sub>DSS</sub>	Drain-to-Source Voltage	60	V
I <sub>D</sub> <sup>a</sup>	Continuous Drain Current	109	A
I <sub>DM</sub>	Pulsed Drain Current @V <sub>G</sub> =10V	436	
P <sub>D</sub>	Power Dissipation	150	W
	Derating Factor above 25°C	1.00	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	+/-20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (L=1mH, I <sub>AS</sub> =40A)	800	mJ
I <sub>AS</sub>	Pulsed Avalanche Energy	Figure 7	A
T <sub>J</sub> and T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55 to 175	°C

## Thermal Resistance

Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
R <sub>θJC</sub>	Junction-to-Case			1.00	°C/W	Water cooled heatsink, P <sub>D</sub> adjusted for a peak junction Temperature of 175°C
R <sub>θJA</sub>	Junction-to-Ambient			62		1 cubic foot chamber, free air

Note:

a: Calculated continuous current based upon maximum allowable junction temperature +175°C. Package limitation current is 80A.

**OFF Characteristics** $T_J=25^\circ C$  unless otherwise specified

Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
$B_{VDSS}$	Drain-to-Source Breakdown Voltage	60			V	$V_{GS}=0V, I_D=250\mu A$
$I_{DSS}$	Drain-to-Source Leakage Current		1	100	uA	$V_{DS}=48V, V_{GS}=0V$
						$V_{DS}=48V, V_{GS}=0V, T_J=125^\circ C$
$I_{GSS}$	Gate-to-Source Forward Leakage			100	nA	$V_{GS}=+20V$
	Gate-to-Source Reverse Leakage			100		$V_{GS}=-20V$

**ON Characteristics** $T_J=25^\circ C$  unless otherwise specified

Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
$R_{DS(ON)}$	Static Drain-to-Source On-Resistance		6.3	8	mΩ	$V_{GS}=10V, I_D=24A$
$V_{GS(TH)}$	Gate Threshold Voltage.	2		4	V	$V_{GS}=V_{DS}, I_D=250\mu A$

**Dynamic Characteristics**

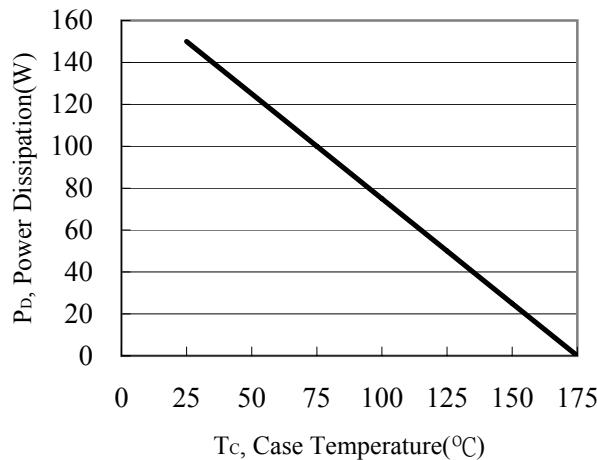
Essentially independent of operating temperature

Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
$C_{iss}$	Input Capacitance		3395		pF	$V_{GS}=0V, V_{DS}=25V, f=1.0MHz$
$C_{oss}$	Output Capacitance		435			
$C_{rss}$	Reverse Transfer Capacitance		150			
$Q_g$	Total Gate Charge		50		nC	$V_{DD}=30V, I_D=38A, V_{GS}=10V$
$Q_{gs}$	Gate-to-Source Charge		21			
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		14			
$T_{d(on)}$	Turn-in Delay Time		14		nS	$V_{DD}=30V, I_D=38A, V_G=10V, R_G=2.5\Omega$
$T_r$	Rise Time		43			
$T_{d(off)}$	Turn-off Delay Time		31			
$T_f$	Fall Time		11			

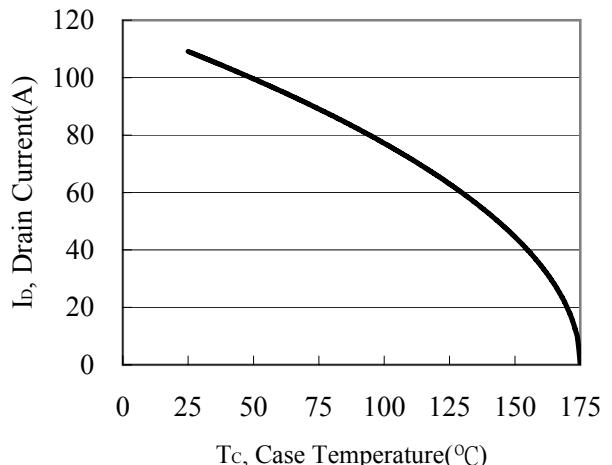
**Source-Drain Diode Characteristics** $T_J=25^\circ C$  unless otherwise specified

Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
$V_{SD}$	Diode Forward Voltage			1.2	V	$I_S=30A, V_{GS}=0V$
$t_{rr}$	Reverse Recovery Time			52	ns	$IF=38Amps,$
$Q_{rr}$	Reverse Recovery Charge			74	nC	$di/dt=100Amps/uS$

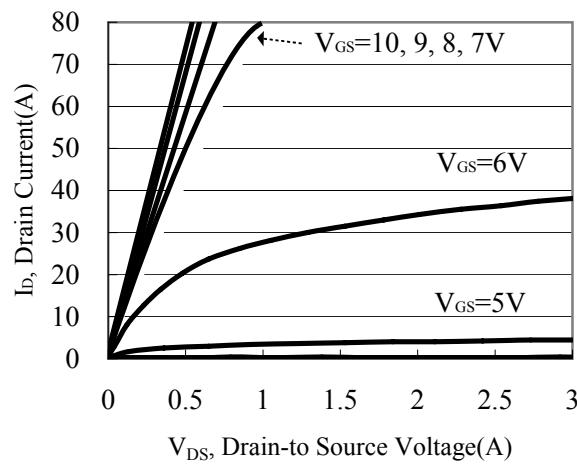
**Figure 1. Maximum Power Dissipation V.S Case Temperature**



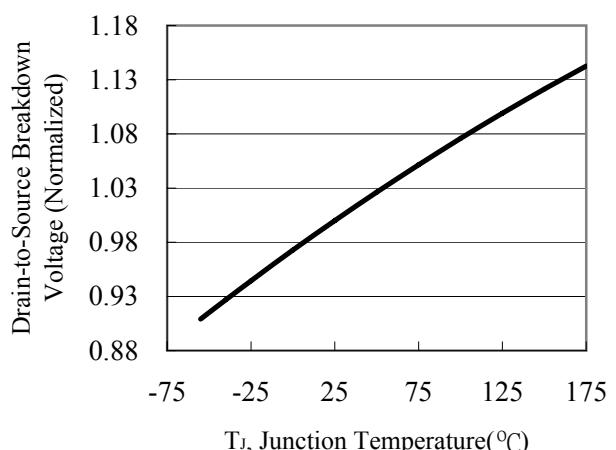
**Figure 2. Maximum Continuous Drain Current V.S Case Temperature**



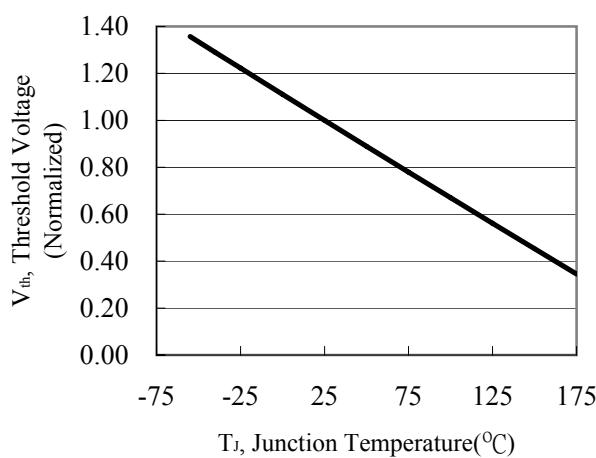
**Figure 3. Typical Output Characteristics**



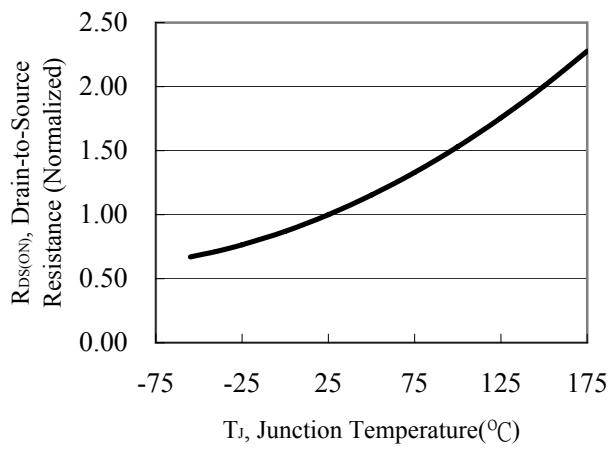
**Figure 4. Breakdown Voltage V.S Junction Temperature**



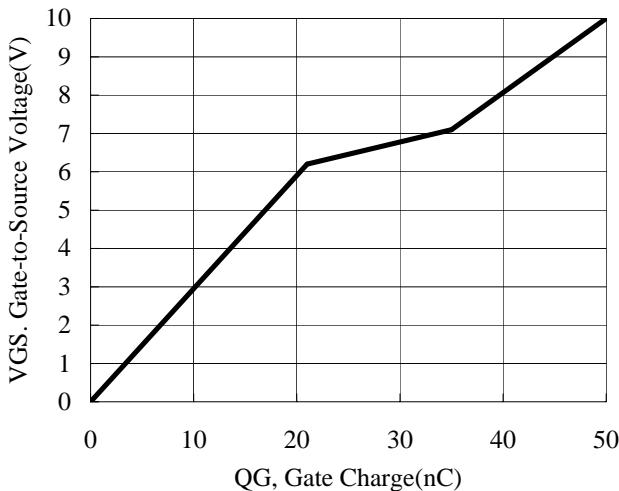
**Figure 5. Threshold Voltage V.S Junction Temperature**



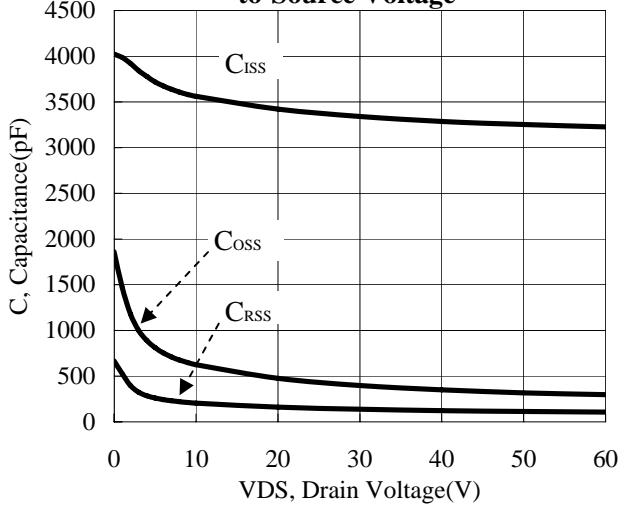
**Figure 6. Drain-to-Source Resistance V.S Junction Temperature**



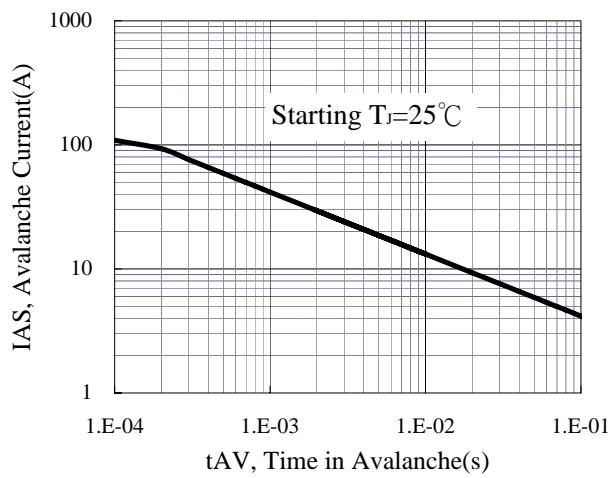
**Figure 7. Typical Gate Charge vs. Gate-to-Source Voltage**



**Figure 8. Typical Capacitance vs. Drain-to-Source Voltage**



**Figure 9. Unclamped Inductive Switching Capability**



**Figure 10. Source-Drain Diode Forward Voltage**

